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PATENT APPLICATION

Applicant TRADEMARK OFFICE

IN THE U.S. PATENT AND TRADEMARK OFFICE

Hiroshi SEKIYA

Title : LIQUID SPRAY UNIT, METHOD OF SPRAYING  
LIQUID USING IT, AND CHEMICAL

Serial No. : 10/522 648 Group: 3752

Confirmation No.: 7545

Filed : September 12, 2005 Examiner: Nguyen

International Application No.: PCT/JP2002/009371

International Filing Date : September 12, 2002

Atty. Docket No.: 4414.P0668US

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

**FIRST CLASS MAILING CERTIFICATE**

Sir:

I hereby certify that this correspondence is being deposited with the United States Postal Service under 37 CFR 1.8 as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on January 31, 2007.

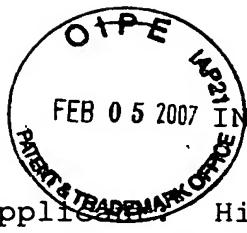
  
Terryence F. Chapman

TFC/smd

FLYNN, THIEL, BOUTELL & TANIS, P.C. 2026 Rambling Road Kalamazoo, MI 49008-1631 Phone: (269) 381-1156 Fax: (269) 381-5465	Dale H. Thiel David G. Boutell Terryence F. Chapman Mark L. Maki Liane L. Churney Brian R. Tumm Steven R. Thiel Donald J. Wallace Sidney B. Williams, Jr.	Reg. No. 24 323 Reg. No. 25 072 Reg. No. 32 549 Reg. No. 36 589 Reg. No. 40 694 Reg. No. 36 328 Reg. No. 53 685 Reg. No. 43 977 Reg. No. 24 949
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Correspondence: Information Disclosure Statement  
dated January 31, 2007  
including enclosures listed thereon

190.05/05



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FEB 05 2007 IN THE U.S. PATENT AND TRADEMARK OFFICE

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## INFORMATION DISCLOSURE STATEMENT

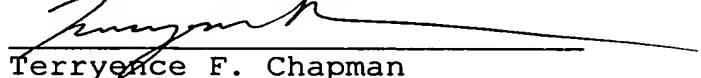
Sir:

In compliance with the provisions of Rules 1.97(e)(1) and 1.98, enclosed herewith is a copy of the European Patent Office Search Report, Form PTO-1449 and the references cited thereon. The relevance of these references is explained on the enclosed search report. Accordingly, further comment at this point in time should not be necessary. Copies of cited U.S. references are not submitted in accordance with 37 CFR 1.98(a).

I hereby certify that each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

Further consideration is respectfully solicited.

Respectfully submitted,

  
Terryence F. Chapman

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Encl: Copy of European Patent Office Search Report  
dated December 12, 2006 (3 pages)

Form PTO-1449 and Non-U.S. references cited thereon  
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110.0703

FEB 05 2007

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INFORMATION  
DISCLOSURE  
CITATION

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## U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA	5 413 314	05-09-1995	PLATA et al
	AB	5 115 972	05-26-1992	MAIER et al
	AC	5 098 018	03-24-1992	HADAR et al
	AD	4 377 985	03-29-1983	REBA
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	AH			
	AI			
	AJ			
	AK			

## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	WO 93/01893	02-04-1993	EHRENBERG et al	
	AM	FR 1 448 577	08-05-1966	GLAVERBEL	No
	AN				
	AO				
	AP				

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
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EXAMINER SIGNATURE	DATE CONSIDERED
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.